## Notice of References Cited Application/Control No. 10/620,401 Examiner Van T Trieu Applicant(s)/Patent Under Reexamination AKER ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,580,386	06-2003	Aker et al.	342/104
*	В	US-6,198,427	03-2001	Aker et al.	342/114
*	С	US-5,691,724	11-1997	Aker et al.	342/104
*	D	US-5,525,996	06-1996	Aker et al.	342/104
*	Е	US-6,411,874	06-2002	Morgan et al.	701/36
*	F	US-6,400,309	06-2002	Jones, David W.	342/104
*	G	US-4,740,045	04-1988	Goodson et al.	342/112
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	υ							
	V							
	W							
	×							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.